

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/670,434	HAO ET AL.	
Examiner Khiem D. Nguyen		Art Unit 2823	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,596,594	07-2003	Guo, Jyh-Chyurn	438/279
*	B	US-2004/0043568	03-2004	Ker et al.	438/279
*	C	US-6,495,885	12-2002	Ahmad et al.	257/336
*	D	US-6,071,825	06-2000	Deferm, Ludo	438/719
*	E	US-6,858,507	02-2005	Ahmad et al.	438/303
*	F	US-2002/0195626	12-2002	Tran et al.	257/285
*	G	US-2002/0190315	12-2002	Ahmad et al.	257/336
*	H	US-2001/0018255	08-2001	Kim et al.	438/305
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
.	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.